

**Search Notes**

Application/Control No.

10/621,572

Examiner

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Applicant(s)/Patent under  
Reexamination

ITABASHI, AKIHISA

Art Unit

2861

**SEARCHED**

Class	Subclass	Date	Examiner
347	241-245, 256-261	5/31/2005	HP
359	212	5/31/2005	HP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	5/31/2005	HP